Search Notes

Application/Control No.	/Control No. Applicant(s)/Patent under Reexamination	
09/830,790	YUAN, YILIAN	
Examiner	Art Unit	

3622

Nicholas Kim

	SEARCHED				
Class	Subclass	Date	Examiner		
705	14	8/25/2005	NK		
			-		
			<u> </u>		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Proquest (see attached)	8/25/2005	NK	
jstor (see attached)	8/25/2005	NK	
EAST (see attached)	8/25/2005	NK	
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